





60V N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

V _{(BR)DSS}	R _{DS(on)}	I _D T _A = 25°C	
601/	68mΩ @ V _{GS} = 10V	8.5A	
60V	100mΩ @ V _{GS} = 4.5V	7.0A	

Description and Applications

This MOSFET has been designed to minimize the on-state resistance $(R_{DS(on)})$ and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Motor Control
- · Transformer Driving Switch
- DC-DC Converters
- Power Management Functions
- Uninterrupted Power Supply

Features and Benefits

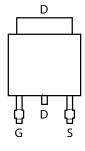
- 100% Unclamped Inductive Switch (UIS) test in production
- Low on-resistance
- Fast switching speed
- "Green" component and RoHS compliant (Note 1)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

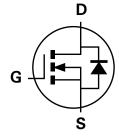
- Case: TO252-3L
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0 (Note 1)
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals Connections: See Diagram
- Terminals: Matte Tin Finish annealed over Copper leadframe.
 Solderable per MIL-STD-202, Method 208
- · Weight: 0.33 grams (approximate)







PIN OUT -TOP



Equivalent Circuit

Ordering Information (Note 1)

Product	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel	
DMN6068LK3-13	N6068L	13	16	2,500	

Note: 1. Diodes, Inc. defines "Green" products as those which are RoHS compliant and contain no halogens or antimony compounds; further information about Diodes Inc.'s "Green" Policy can be found on our website. For packaging details, go to our website.

Marking Information



O!! = Manufacturer's Marking
N6068L = Product Type Marking Code
YYWW = Date Code Marking
YY = Year (ex: 09 = 2009)
WW = Week (01-52)





Maximum Ratings @T_A = 25°C unless otherwise specified

Cha	aracteristic		Symbol	Value	Unit	
Drain-Source voltage			V_{DSS}	60	V	
Gate-Source voltage (Note 2)			V_{GS}	±20	V	
Single Pulsed Avalanche En	ergy	(Note 8)	E _{AS}	37.5	mJ	
Single Pulsed Avalanche Current (Note 8)		(Note 8)	I _{AS}	5.0	Α	
		(Note 4)	I _D	8.5		
Continuous Drain current	$V_{GS} = 10V$	$T_A = 70^{\circ}C \text{ (Note 4)}$		6.8	Α	
		(Note 3)		6.0		
Pulsed Drain current	V _{GS} = 10V	(Note 5)	I _{DM}	22.2	Α	
Continuous Source current (ontinuous Source current (Body diode) (Note 4)		I _S	10.2	Α	
Pulsed Source current (Body diode) (No		(Note 5)	I _{SM}	22.2	Α	

Thermal Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Value	Unit	
	(Note 3)		4.12 33	
Linear derating factor	(Note 4)	P _D	8.49 67.9	W mW/°C
	(Note 6)		2.12 16.9	
	(Note 3)		30.3	
Thermal Resistance, Junction to Ambient	(Note 4)	$R_{ heta JA}$	14.7	20.004
	(Note 6)		59.0	°C/W
Thermal Resistance, Junction to Lead	(Note 7)	$R_{ heta JL}$	3.09	
Operating and storage temperature range		T _J , T _{STG}	-55 to 150	°C

Notes:

- 2. AEC-Q101 V_{GS} maximum is $\pm 16V$.
- 3. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

- ## Reasured when operating in a steady-state condition.

 4. Same as note 2, except the device is measured at t ≤ 10 sec.

 5. Same as note 2, except the device is pulsed with D = 0.02 and pulse width 300 μs. The pulse current is limited by the maximum junction temperature.

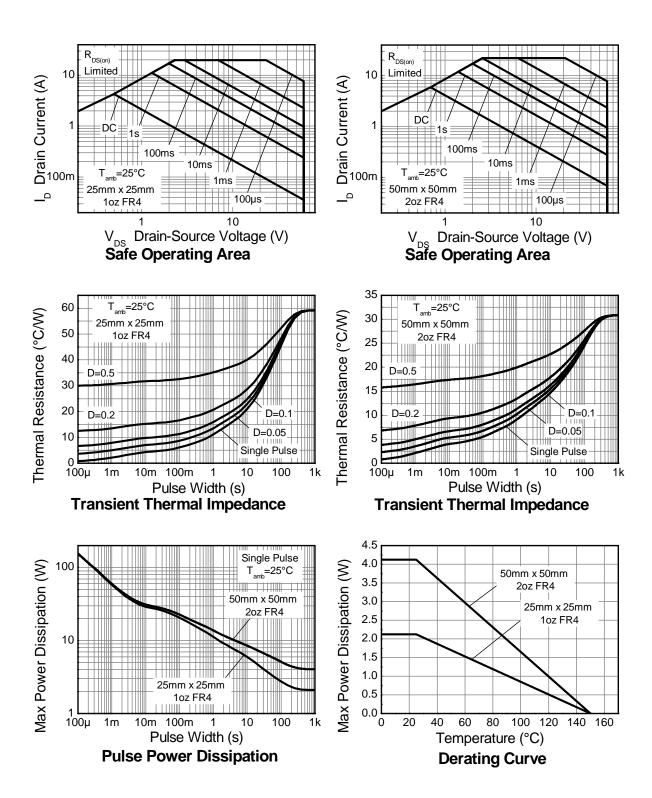
 6. For a device surface mounted on 25mm x 15mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions; the device is measured when operating in a steady-state condition.

 7. The real resistance from irregion to solder point (at the end of the drain lead).
- 7. Thermal resistance from junction to solder-point (at the end of the drain lead).
- 8. UIS in production with L = 3.0mH, I_{AS} = 5.0Å, R_{G} = 25 Ω , V_{DD} = 50V, starting T_{J} = 25 $^{\circ}$ C





Thermal Characteristics







Electrical Characteristics @TA = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test C	ondition
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage	BV _{DSS}	60	_	_	V	$I_D = 250 \mu A, V_{GS}$	= 0V
Zero Gate Voltage Drain Current	I _{DSS}	_	_	0.5	μА	V _{DS} = 60V, V _{GS} =	0V
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	V _{GS} = ±20V, V _{DS}	= 0V
ON CHARACTERISTICS							
Gate Threshold Voltage	V _{GS(th)}	1.0		3.0	V	I _D = 250μA, V _{DS} =	= V _{GS}
Static Drain-Source On-Resistance (Note 9)	Dec (cu)			0.068	Ω	V _{GS} = 10V, I _D = 1	2A
Static Dialif-Source Off-Resistance (Note 9)	R _{DS} (ON)	_		0.100	22	$V_{GS} = 4.5V, I_{D} = 6$	SA .
Forward Transconductance (Notes 9 & 10)	g _{fs}	_	19.7	_	S	V _{DS} = 15V, I _D = 1	2A
Diode Forward Voltage (Note 9)	V_{SD}	_	0.98	1.15	٧	I _S = 12A, V _{GS} = 0	V
Reverse recovery time (Note 10)	t _{rr}		145	_	ns	I _S = 12A, di/dt= 100A/μs	
Reverse recovery charge (Note 10)	Q _{rr}	_	929	_	nC		
DYNAMIC CHARACTERISTICS (Note 10)							
Input Capacitance	C _{iss}	_	502	_	pF	.,	
Output Capacitance	Coss	_	45.7	_	pF	V _{DS} = 30V, V _{GS} = 0V f= 1MHz	
Reverse Transfer Capacitance	C _{rss}	_	27.1	_	pF	1= 1101112	_
Total Gate Charge	Qg	_	5.55	_	nC	V _{GS} = 4.5V	
Total Gate Charge	Qg	_	10.3	_	nC		V _{DS} = 30V
Gate-Source Charge	Q_{gs}	_	1.6	_	nC	V _{GS} = 10V I _D = 12A	
Gate-Drain Charge	Q_{gd}	_	3.5	_	nC]	
Turn-On Delay Time (Note 11)	t _{D(on)}	_	3.6	_	ns		
Turn-On Rise Time (Note 11)	t _r	_	10.8		ns	V _{DD} = 30V, V _{GS} = 10V	
Turn-Off Delay Time (Note 11)	t _{D(off)}	_	11.9		ns	$I_D=12A, R_G \cong 6.0\Omega$	
Turn-Off Fall Time (Note 11)	t _f	_	8.7	_	ns	<u> </u>	

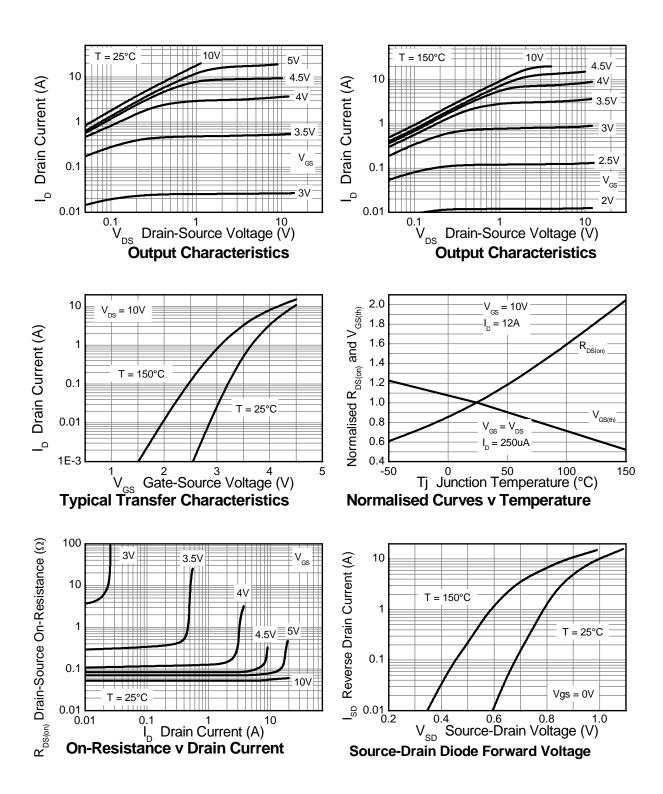
Notes:

- 9. Measured under pulsed conditions. Pulse width $\leq 300 \mu s;$ duty cycle $\leq 2\%$ 10. For design aid only, not subject to production testing.
- 11. Switching characteristics are independent of operating junction temperatures.





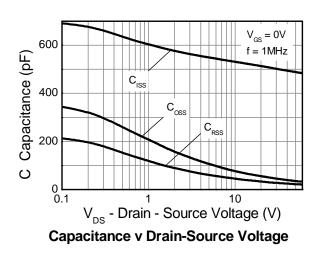
Typical Characteristics

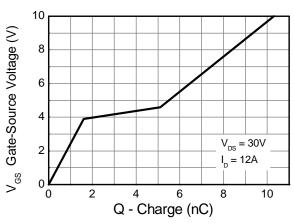




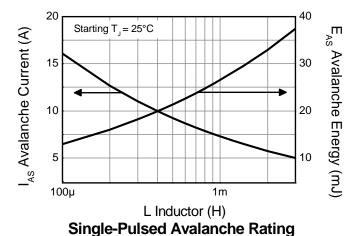


Typical Characteristics - continued





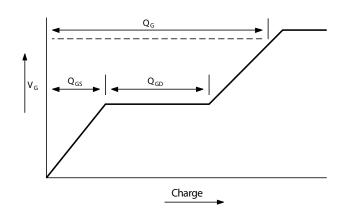
Gate-Source Voltage v Gate Charge

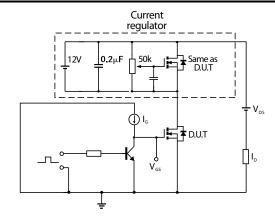






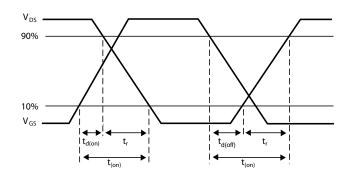
Test Circuits

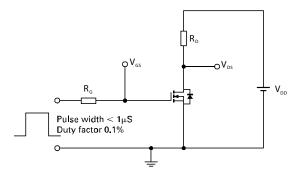




Basic gate charge waveform

Gate charge test circuit



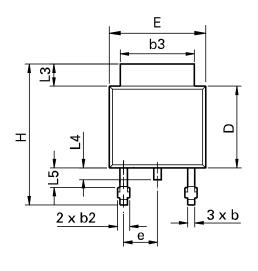


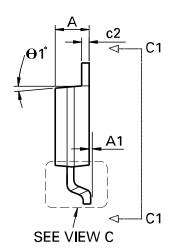
Switching time waveforms

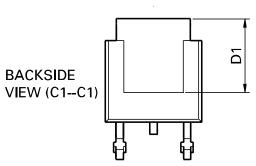
Switching time test circuit

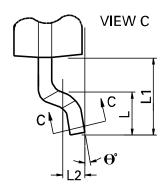


Package Outline Dimensions





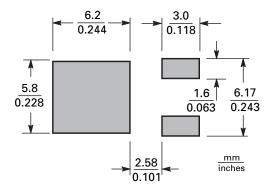




DIM	DIM Inches		Millimeters		DIM	Inches		Millimeters	
	Min	Max	Min	Max		Min	Max	Min	Max
Α	0.086	0.094	2.18	2.39	е	0.090 BSC		2.29 BSC	
A1	-	0.005	-	0.127	Н	0.370	0.410	9.40	10.41
b	0.020	0.035	0.508	0.89	L	0.055	0.070	1.40	1.78
b2	0.030	0.045	0.762	1.14	L1	0.108 REF		2.74 REF	
b3	0.205	0.215	5.21	5.46	L2	0.020 BSC		0.508 BSC	
С	0.018	0.024	0.457	0.61	L3	0.035	0.065	0.89	1.65
c2	0.018	0.023	0.457	0.584	L4	0.025	0.040	0.635	1.016
D	0.213	0.245	5.41	6.22	L5	0.045	0.060	1.14	1.52
D1	0.205	-	5.21	-	θ1°	0°	10°	0°	10°
E	0.250	0.265	6.35	6.73	θ°	0°	15°	0°	15°
E1	0.170	-	4.32	-	-	-	-	-	_



Suggested Pad Layout



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